## **Power MOSFET** 30 V, 171 A, Single N-Channel, SO-8 FL

#### Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Includes Schottky Diode
- Optimized Gate Charge to Minimize Switching Losses
- Dual Sided Cooling Capability
- These are Pb-Free Device

#### Applications

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise stated)

| Para  | ameter                |                       | Symbol                               | Value          | Unit |
|---|-----------------------|-----------------------|--------------------------------------|----------------|------|
| Drain-to-Source Vo  | Itage                 |                       | V <sub>DSS</sub>                     | 30             | V    |
| Gate-to-Source Vol  | tage                  |                       | V <sub>GS</sub>                      | ±20            | V    |
| Continuous Drain  |                       | T <sub>A</sub> = 25°C | Ι <sub>D</sub>                       | 29             | А    |
| Current R <sub>θJA</sub><br>(Note 1)  |                       | T <sub>A</sub> = 85°C |                                      | 21             |      |
| Power Dissipation $R_{\theta JA}$ (Note 1)  |                       | T <sub>A</sub> = 25°C | P <sub>D</sub>                       | 2.74           | W    |
| Continuous Drain  |                       | T <sub>A</sub> = 25°C | Ι <sub>D</sub>                       | 47             | А    |
| Current $R_{\theta JA} \leq$ 10 sec   |                       | T <sub>A</sub> = 85°C |                                      | 34             |      |
| Power Dissipation $R_{\theta JA,} t \leq 10 \text{ sec}$  | Steady                | T <sub>A</sub> = 25°C | P <sub>D</sub>                       | 7.3            | W    |
| Continuous Drain<br>Current R <sub>θJA</sub>  | State                 | T <sub>A</sub> = 25°C | I <sub>D</sub>                       | 17             | А    |
| (Note 2)  |                       | T <sub>A</sub> = 85°C |                                      | 12             |      |
| Power Dissipation $R_{\theta JA}$ (Note 2)  |                       | T <sub>A</sub> = 25°C | PD                                   | 0.95           | W    |
| Continuous Drain  |                       | T <sub>C</sub> = 25°C | Ι <sub>D</sub>                       | 171            | А    |
| Current R <sub>θJC</sub><br>(Note 1)  |                       | T <sub>C</sub> = 85°C |                                      | 123            |      |
| Power Dissipation $R_{\theta JC}$ (Note 1)  |                       | T <sub>C</sub> = 25°C | PD                                   | 96.2           | W    |
| Pulsed Drain<br>Current   | t <sub>p</sub> =10μs  | T <sub>A</sub> = 25°C | I <sub>DM</sub>                      | 288            | A    |
| Current limited by pa   | ickage                | T <sub>A</sub> = 25°C | I <sub>Dmaxpkg</sub>                 | 100            | А    |
| Operating Junction a<br>Temperature   | nd Storage            | •                     | T <sub>J</sub> ,<br>T <sub>STG</sub> | –40 to<br>+150 | °C   |
| Source Current (Boo   | ly Diode)             |                       | ۱ <sub>S</sub>                       | 120            | А    |
| Drain to Source dV/c  | Drain to Source dV/dt |                       |                                      | 6              | V/ns |
| $ \begin{array}{l} \mbox{Single Pulse Drain-to-Source Avalanche} \\ \mbox{Energy (V}_{DD} = 50 \mbox{ V, V}_{GS} = 10 \mbox{ V,} \\ \mbox{I}_L = 50 \mbox{ A}_{pk}, \mbox{ L} = 0.3 \mbox{ mH, R}_G = 25 \Omega ) \end{array} $ |                       |                       | EAS                                  | 375            | mJ   |
| Lead Temperature for (1/8" from case for 1  |                       | Purposes              | ΤL                                   | 260            | °C   |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

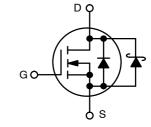


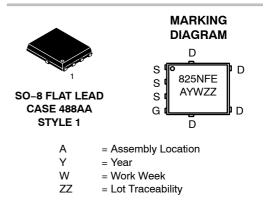
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#### http://onsemi.com

| V <sub>(BR)DSS</sub> | R <sub>DS(ON)</sub> MAX | I <sub>D</sub> MAX |
|----------------------|-------------------------|--------------------|
| 30 V                 | 2.0 mΩ @ 10 V           | 171 A              |
| 50 V                 | 3.0 mΩ @ 4.5 V          | 140 A              |







#### **ORDERING INFORMATION**

| Device          | Package             | Shipping <sup>†</sup> |
|-----------------|---------------------|-----------------------|
| NTMFS4825NFET1G | SO-8FL<br>(Pb-Free) | 1500 /<br>Tape & Reel |
| NTMFS4825NFET3G | SO-8FL<br>(Pb-Free) | 5000 /<br>Tape & Reel |

+ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter                                   | Symbol          | Value | Unit |
|---|-----------------|-------|------|
| Junction-to-Case (Drain)                    | $R_{\theta JC}$ | 1.3   |      |
| Junction-to-Ambient - Steady State (Note 1) | $R_{\theta JA}$ | 45.7  | 1    |
| Junction-to-Ambient - Steady State (Note 2) | $R_{\theta JA}$ | 132.1 | °C/W |
| Junction-to-Ambient – t $\leq$ 10 sec       | $R_{	hetaJA}$   | 17.2  | 1    |
| Junction-to-Top                             | $R_{\theta JT}$ | 7.0   |      |

1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

2. Surface-mounted on FR4 board using the minimum recommended pad size.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise specified)

| Parameter  | Symbol                                   | Test Condition                                   |                        | Min | Тур  | Max  | Unit  |
|--|--|--|------------------------|-----|------|------|-------|
| OFF CHARACTERISTICS  |  |  |                        |     |      |      |       |
| Drain-to-Source Breakdown Voltage                            | V <sub>(BR)DSS</sub>                     | V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1.0 mA   |                        | 30  |      |      | V     |
| Drain-to-Source Breakdown Voltage<br>Temperature Coefficient | V <sub>(BR)DSS</sub> /<br>T <sub>J</sub> |  |                        |     | 28.5 |      | mV/°C |
| Zero Gate Voltage Drain Current                              | I <sub>DSS</sub>                         | V <sub>GS</sub> = 0 V,<br>V <sub>DS</sub> = 24 V | T <sub>J</sub> = 25 °C |     | 60   | 500  | μΑ    |
| Gate-to-Source Leakage Current                               | I <sub>GSS</sub>                         | $V_{DS}$ = 0 V, $V_{GS}$                         | = ±20 V                |     |      | ±100 | nA    |

#### **ON CHARACTERISTICS** (Note 3)

| Gate Threshold Voltage                     | V <sub>GS(TH)</sub>                 | $V_{GS} = V_{DS}$ , $I_D = 1.0 \text{ mA}$    |                       | 1.5 | 2.0 | 2.5 | V     |
|--|-------------------------------------|---|-----------------------|-----|-----|-----|-------|
| Negative Threshold Temperature Coefficient | V <sub>GS(TH)</sub> /T <sub>J</sub> |   | _                     |     | 4   |     | mV/°C |
| Drain-to-Source On Resistance              | R <sub>DS(on)</sub>                 | V <sub>GS</sub> = 10 V                        | I <sub>D</sub> = 22 A |     | 1.3 | 2.0 |       |
|  |                                     |   | I <sub>D</sub> = 20 A |     | 1.3 |     |       |
|  |                                     | V <sub>GS</sub> = 4.5 V                       | I <sub>D</sub> = 20 A |     | 2.0 | 3.0 | mΩ    |
|  |                                     |   | I <sub>D</sub> = 18 A |     | 2.0 |     |       |
| Forward Transconductance                   | 9 <sub>FS</sub>                     | V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A |                       |     | 90  |     | S     |

#### **CHARGES AND CAPACITANCES**

| Input Capacitance            | C <sub>ISS</sub>    |  | 5660 |    |
|------------------------------|---------------------|--|------|----|
| Output Capacitance           | C <sub>OSS</sub>    | $V_{GS}$ = 0 V, f = 1 MHz, $V_{DS}$ = 15 V                             | 1150 | pF |
| Reverse Transfer Capacitance | C <sub>RSS</sub>    |  | 495  |    |
| Total Gate Charge            | Q <sub>G(TOT)</sub> |  | 40.2 |    |
| Threshold Gate Charge        | Q <sub>G(TH)</sub>  |  | 6.4  | nC |
| Gate-to-Source Charge        | Q <sub>GS</sub>     | V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 23 A | 15.3 | nc |
| Gate-to-Drain Charge         | Q <sub>GD</sub>     |  | 13.4 |    |
| Total Gate Charge            | Q <sub>G(TOT)</sub> | $V_{GS}$ = 10 V, $V_{DS}$ = 15 V,<br>I <sub>D</sub> = 23 A             | 83.6 | nC |

#### SWITCHING CHARACTERISTICS (Note 4)

| Turn-On Delay Time  | t <sub>d(ON)</sub>  |  | 26 |    |
|---------------------|---------------------|--|----|----|
| Rise Time           | t <sub>r</sub>      | V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V, | 24 |    |
| Turn-Off Delay Time | t <sub>d(OFF)</sub> | $I_D$ = 15 A, $R_G$ = 3.0 $\Omega$               | 36 | ns |
| Fall Time           | t <sub>f</sub>      |  | 13 |    |

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

| Parameter                     | Symbol              | Test Condition  |                       | Min  | Тур  | Max | Unit |
|-------------------------------|---------------------|---|-----------------------|------|------|-----|------|
| SWITCHING CHARACTERISTICS (No | ote 4)              |   |                       |      |      |     |      |
| Turn-On Delay Time            | t <sub>d(ON)</sub>  |   |                       |      | 15.7 |     |      |
| Rise Time                     | t <sub>r</sub>      | V <sub>GS</sub> = 10 V, V <sub>D</sub>  | <sub>IS</sub> = 15 V, |      | 21.2 |     | ns   |
| Turn-Off Delay Time           | t <sub>d(OFF)</sub> | $I_{\rm D} = 15  \rm A,  R_{\rm G}$   | = 3.0 Ω               |      | 44.6 |     |      |
| Fall Time                     | t <sub>f</sub>      | 1   |                       |      | 14.5 |     | 1    |
| DRAIN-SOURCE DIODE CHARACTE   | ERISTICS            |   |                       |      |      |     |      |
| Forward Diode Voltage         | V <sub>SD</sub>     | $V_{GS} = 0 V, I_{S} = 2.0 A T_{J} = 25^{\circ}C T_{J} = 125^{\circ}C$                                  |                       | 0.35 | 0.70 | Ň   |      |
|                               |                     |   |                       | 0.26 |      | V   |      |
| Reverse Recovery Time         | t <sub>RR</sub>     | ·   |                       |      | 39.1 |     |      |
| Charge Time                   | t <sub>a</sub>      | V <sub>GS</sub> = 0 V, dI <sub>S</sub> /dt  | = 100 A/μs,           |      | 20.1 |     | ns   |
| Discharge Time                | t <sub>b</sub>      | $V_{GS} = 0 \text{ V}, \text{ dI}_S/\text{dt} = 100 \text{ A}/\mu\text{s},$ $\text{I}_S = 23 \text{ A}$ |                       |      | 19   |     |      |
| Reverse Recovery Charge       | Q <sub>RR</sub>     |   |                       |      | 34   |     | nC   |
| PACKAGE PARASITIC VALUES      |                     |   |                       |      |      |     |      |
| Source Inductance             | L <sub>S</sub>      | − T <sub>A</sub> = 25°C   |                       |      | 0.66 |     | nH   |
| Drain Inductance              | L <sub>D</sub>      |   |                       |      | 0.20 |     |      |
| Gate Inductance               | L <sub>G</sub>      |   |                       |      | 1.5  |     |      |
|                               |                     |   |                       |      |      |     |      |

0.7

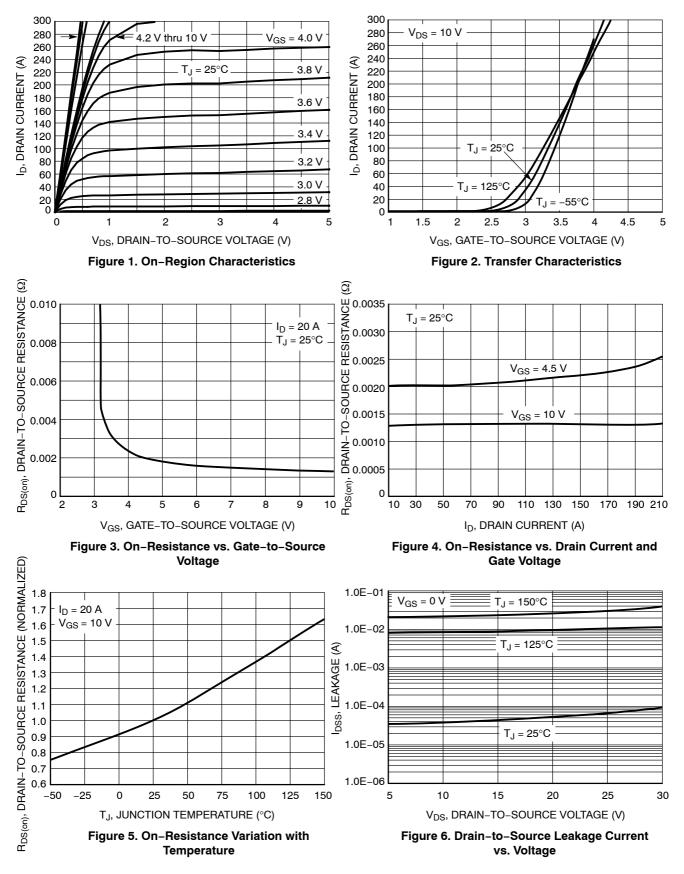
2.0

Ω

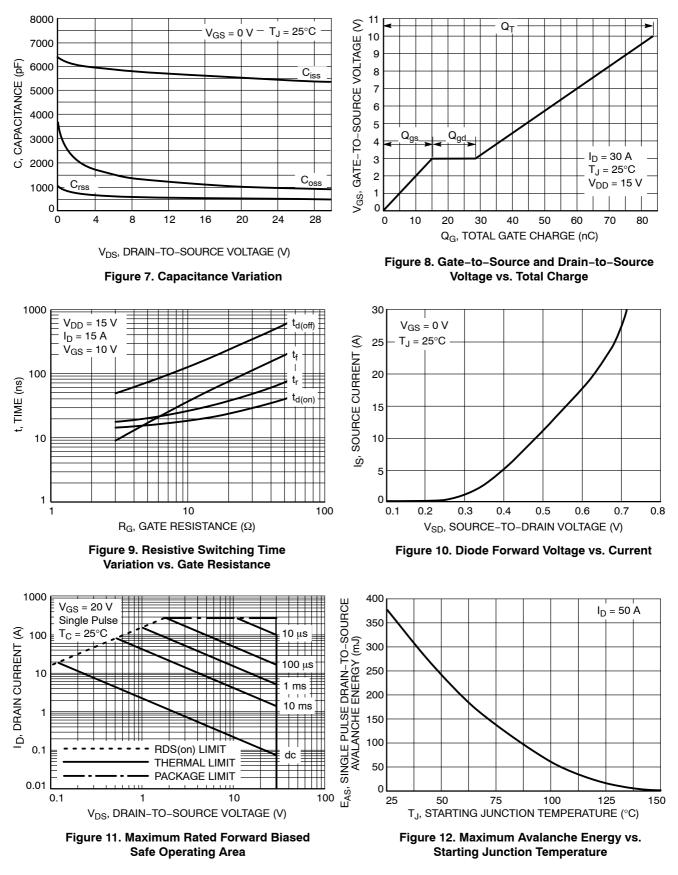
Gate Resistance

 $\mathsf{R}_\mathsf{G}$ 

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